

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
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S Servizio svizzero di taratura
S Swiss Calibration Service

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The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.



DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1µV , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec.

Calibration Factors	X	Y	Z
High Range	404.759 ± 0.1% (k=2)	403.533 ± 0.1% (k=2)	405.087 ± 0.1% (k=2)
Low Range	3.98990 ± 0.7% (k=2)	3.96736 ± 0.7% (k=2)	3.99650 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	308,5 ° ± 1 °
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Appendix

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	199989.9	-19.33	-0.01
Channel X + Input	19998.71	-1.49	-0.01
Channel X - Input	-19997.52	2.48	-0.01
Channel Y + Input	200005.5	-2.55	-0.00
Channel Y + Input	19998.69	-1.31	-0.01
Channel Y - Input	-20000.77	-1.07	0.01
Channel Z + Input	199996.6	-1.53	-0.00
Channel Z + Input	19995.31	-4.89	-0.02
Channel Z - Input	-20004.85	0.02	0.02

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	1999.2	-0.67	-0.03
Channel X + Input	198.75	-1.25	-0.62
Channel X - Input	-202.40	-2.40	1.20
Channel Y + Input	1999.9	-0.34	-0.02
Channel Y + Input	198.02	-2.08	-1.04
Channel Y - Input	-202.77	-2.77	1.38
Channel Z + Input	1998.9	-1.13	-0.06
Channel Z + Input	197.15	-2.65	-1.33
Channel Z - Input	-202.66	-2.76	1.38

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-11.65	-12.94
	-200	5.27	4.21
Channel Y	200	-1.68	-2.17
	-200	0.94	0.50
Channel Z	200	-10.40	-10.34
	-200	7.99	8.37

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	3.78	0.43
Channel Y	200	2.72	-	3.55
Channel Z	200	1.91	-1.15	-



4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16047	16291
Channel Y	16164	15200
Channel Z	16419	16616

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	-0.27	-1.21	0.66	0.34
Channel Y	-1.11	-2.22	0.27	0.51
Channel Z	-1.33	-2.34	-0.31	0.45

6. Input Offset Current

Nominal input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MΩ)	Measuring (MΩ)
Channel X	0.2000	203.5
Channel Y	0.2000	203.3
Channel Z	0.2000	203.9

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+8	+14
Supply (- Vcc)	-0.01	-8	-9



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Accreditation No.: SCS 108

Client Auden

Certificate No: DAE4-910_Sep09

CALIBRATION CERTIFICATE

Object DAE4 - SD 000 D04 BK - SN: 910
Calibration procedure(s) QA CAL-06.v20 Calibration procedure for the data acquisition electronics (DAE)
Calibration date: September 18, 2009
Condition of the calibrated item In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.
All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Primary Standards, ID #, Cal Date (Certificate No.), Scheduled Calibration. Includes entries for Keithley Multimeter Type 2001 and Calibrator Box V1.1.

Calibrated by: Dominique Steffen, Technician
Approved by: Fin Bornholt, R&D Director
Signatures of Dominique Steffen and Fin Bornholt.

Issued: September 18, 2009

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Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASy system to align probe sensor X to the robot coordinate system.

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DC Voltage Measurement

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Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.468 \pm 0.1% (k=2)	402.794 \pm 0.1% (k=2)	403.267 \pm 0.1% (k=2)
Low Range	3.98156 \pm 0.7% (k=2)	3.93790 \pm 0.7% (k=2)	3.95318 \pm 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASYS system	332.5 $^{\circ}$ \pm 1 $^{\circ}$
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Appendix

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	200007.9	0.26	0.00
Channel X + Input	19999.78	-0.42	-0.00
Channel X - Input	-20000.04	-1.04	0.01
Channel Y + Input	199998.4	0.89	0.00
Channel Y + Input	19996.78	-2.72	-0.01
Channel Y - Input	-20001.06	-1.46	0.01
Channel Z + Input	199996.4	-0.15	-0.00
Channel Z + Input	19997.21	-2.39	-0.01
Channel Z - Input	-20000.90	0.01	0.01

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2000.2	0.25	0.01
Channel X + Input	198.01	-1.79	-0.88
Channel X - Input	-201.04	-1.14	0.57
Channel Y + Input	2000.2	-0.04	-0.00
Channel Y + Input	198.23	-1.77	-0.88
Channel Y - Input	-202.23	-2.23	1.12
Channel Z + Input	1999.7	-0.72	-0.04
Channel Z + Input	197.54	-2.46	-1.23
Channel Z - Input	-202.83	-2.83	1.42

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-14.99	-16.70
	-200	18.86	16.76
Channel Y	200	5.73	5.43
	-200	-7.07	-7.23
Channel Z	200	-11.68	-11.63
	-200	10.57	10.18

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	2.48	-1.62
Channel Y	200	2.03	-	5.13
Channel Z	200	2.11	0.30	-



4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16170	16227
Channel Y	15395	15569
Channel Z	16720	16928

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	-0.86	-2.19	0.75	0.58
Channel Y	-0.88	-2.32	0.63	0.57
Channel Z	-1.64	-2.82	0.09	0.57

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <251A

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	198.8
Channel Y	0.1999	198.8
Channel Z	0.1999	199.9

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9



Calibration Certificate of DAS Y

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Accreditation No.: SCS 108

Client **Sporton (Auden)**

Certificate No: **ET3-1788_Sep09**

CALIBRATION CERTIFICATE

Object **ET3DV6 - SN:1788**

Calibration procedure(s) **QA CAL-01.v6, QA CAL-23.v3 and QA CAL-25.v2
Calibration procedure for dosimetric E-field probes**

Calibration date: **September 23, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-09 (No. 217-01030)	Apr-10
Power sensor E4412A	MY41495277	1-Apr-09 (No. 217-01030)	Apr-10
Power sensor E4412A	MY41498087	1-Apr-09 (No. 217-01030)	Apr-10
Reference 3 dB Attenuator	SN: S5054 (3c)	31-Mar-09 (No. 217-01026)	Mar-10
Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-09 (No. 217-01028)	Mar-10
Reference 30 dB Attenuator	SN: S5129 (30b)	31-Mar-09 (No. 217-01027)	Mar-10
Reference Probe ES3DV2	SN: 3013	2-Jan-09 (No. ES3-3013_Jan09)	Jan-10
DAE4	SN: 660	9-Sep-08 (No. DAE4-660_Sep08)	Sep-09

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

Calibrated by:	Name Claudio Leubler	Function Laboratory Technician	Signature
Approved by:	Name Katja Pokovic	Technical Manager	

Issued: September 23, 2009

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Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
Polarization ϕ	ϕ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- *NORM_{x,y,z}*: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). *NORM_{x,y,z}* are only intermediate values, i.e., the uncertainties of *NORM_{x,y,z}* does not effect the E^2 -field uncertainty inside TSL (see below *ConvF*).
- *NORM(f)_{x,y,z}* = *NORM_{x,y,z}* * *frequency_response* (see Frequency Response Chart). This linearization is implemented in DAS Y4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCP_{x,y,z}*: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- *ConvF and Boundary Effect Parameters*: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DAS Y4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to *NORM_{x,y,z}* * *ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DAS Y version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- *Spherical isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



ET3DV6 SN:1788

September 23, 2009

Probe ET3DV6

SN:1788

Manufactured:	May 28, 2003
Last calibrated:	September 23, 2008
Recalibrated:	September 23, 2009

Calibrated for DASYS Systems

(Note: non-compatible with DASYS2 system!)



ET3DV6 SN:1788

September 23, 2009

DASY - Parameters of Probe: ET3DV6 SN:1788

Sensitivity in Free Space^A

Diode Compression^B

NormX	1.79 ± 10.1%	$\mu V/(V/m)^2$	DCP X	95 mV
NormY	1.68 ± 10.1%	$\mu V/(V/m)^2$	DCP Y	98 mV
NormZ	1.74 ± 10.1%	$\mu V/(V/m)^2$	DCP Z	91 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 835 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	10.4	6.8
SAR _{be} [%]	With Correction Algorithm	0.8	0.5

TSL 1750 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	12.5	8.3
SAR _{be} [%]	With Correction Algorithm	0.8	0.4

Sensor Offset

Probe Tip to Sensor Center 2.7 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

^B Numerical linearization parameter: uncertainty not required.

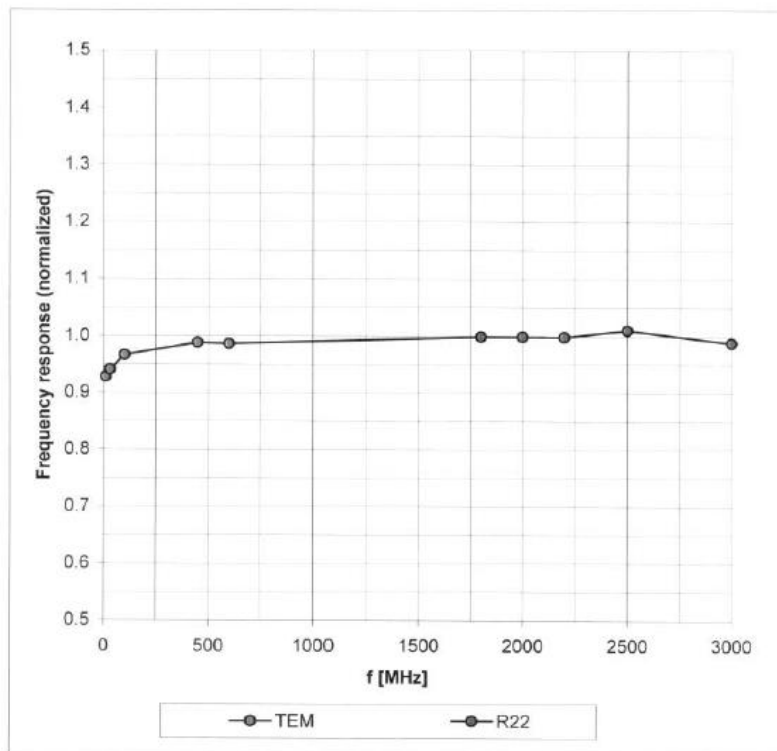


ET3DV6 SN:1788

September 23, 2009

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



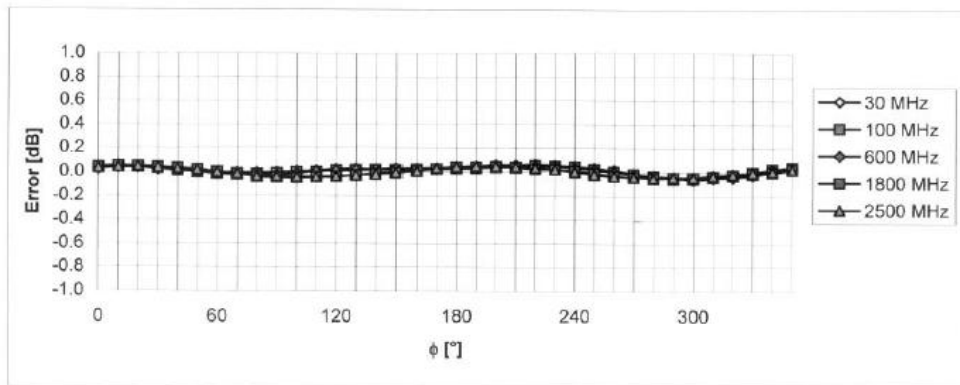
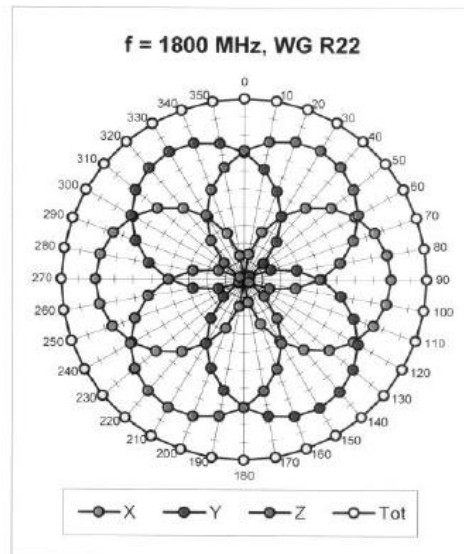
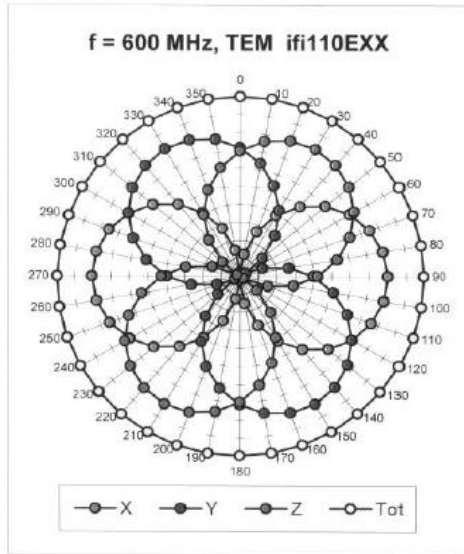
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)



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September 23, 2009

Receiving Pattern (ϕ), $\theta = 0^\circ$



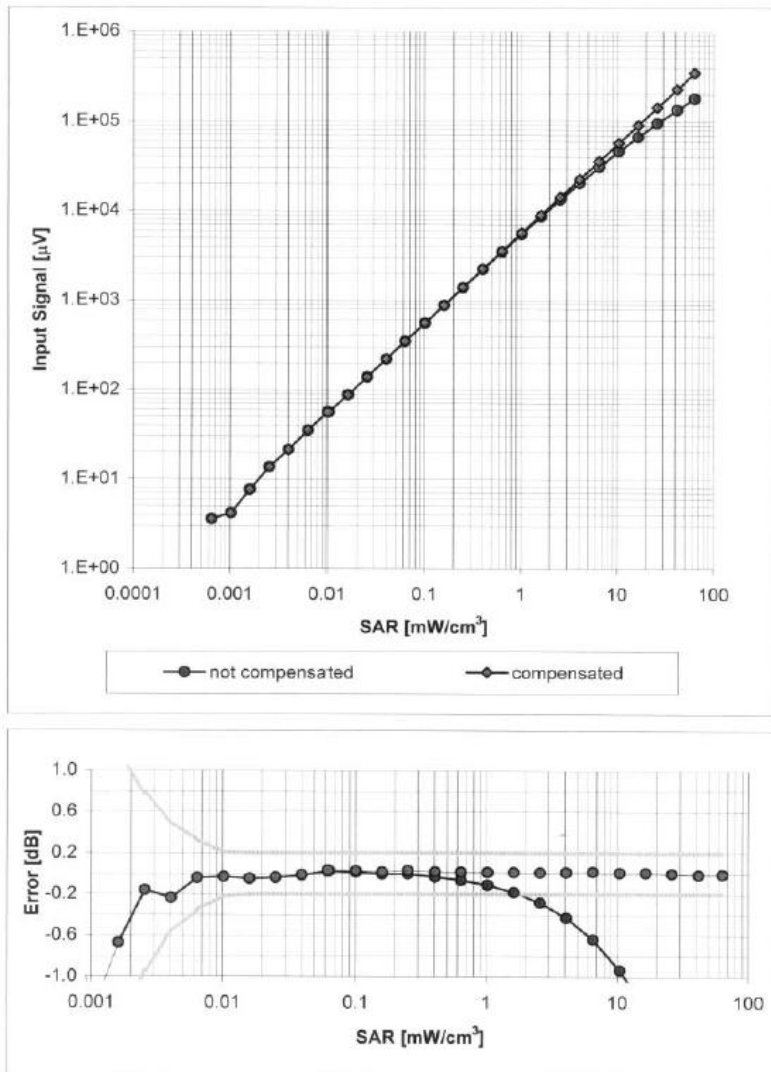
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)



ET3DV6 SN:1788

September 23, 2009

Dynamic Range $f(\text{SAR}_{\text{head}})$ (Waveguide R22, $f = 1800 \text{ MHz}$)

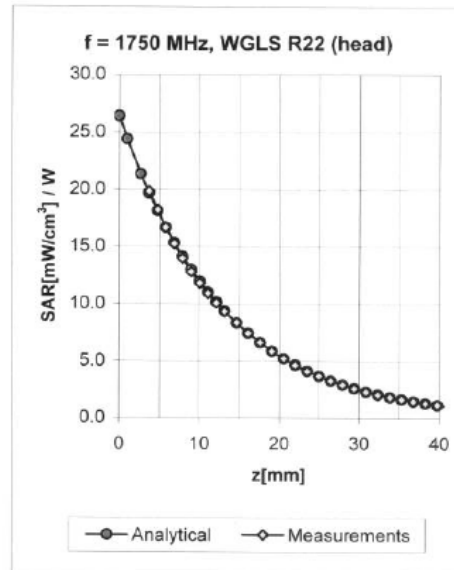
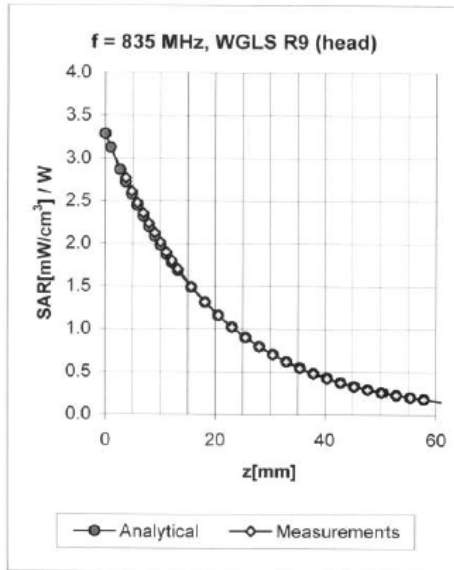


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

ET3DV6 SN:1788

September 23, 2009

Conversion Factor Assessment



f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	0.35	2.50	6.30 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.1 ± 5%	1.37 ± 5%	0.50	2.63	5.40 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.68	2.24	5.11 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.99	1.77	4.48 ± 11.0% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	0.33	2.65	6.08 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.4 ± 5%	1.49 ± 5%	0.58	3.48	4.77 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.75	2.85	4.52 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.99	1.54	4.19 ± 11.0% (k=2)

^c The validity of ± 100 MHz only applies for DAS Y v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

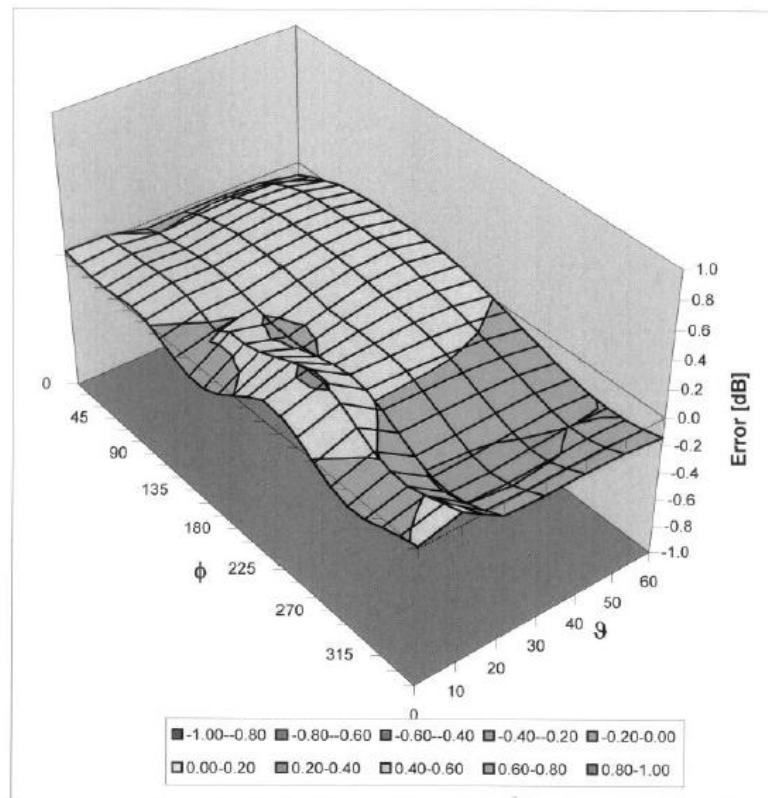


ET3DV6 SN:1788

September 23, 2009

Deviation from Isotropy in HSL

Error (ϕ , θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)



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Accreditation No.: SCS 108

Client Sporton (Auden)

Certificate No: EX3-3731_Jul10

CALIBRATION CERTIFICATE

Object: EX3DV4 - SN:3731
Calibration procedure(s): QA CAL-01.v6, QA CAL-14.v3, QA CAL-23.v3 and QA CAL-25.v2
Calibration procedure for dosimetric E-field probes
Calibration date: July 16, 2010

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Primary Standards, ID #, Cal Date (Certificate No.), Scheduled Calibration. Lists various power meters, sensors, and attenuators with their respective IDs and calibration dates.

Table with 4 columns: Secondary Standards, ID #, Check Date (in house), Scheduled Check. Lists RF generator and Network Analyzer with their IDs and check dates.

Calibrated by: Katja Pokovic, Technical Manager
Approved by: Niels Kuster, Quality Manager

Issued: July 16, 2010

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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- *NORM_{x,y,z}*: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). *NORM_{x,y,z}* are only intermediate values, i.e., the uncertainties of *NORM_{x,y,z}* does not effect the E^2 -field uncertainty inside TSL (see below *ConvF*).
- *NORM(f)_{x,y,z}* = *NORM_{x,y,z}* * *frequency_response* (see Frequency Response Chart). This linearization is implemented in DAS Y4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCP_{x,y,z}*: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- *A_{x,y,z}*; *B_{x,y,z}*; *C_{x,y,z}*; *VR_{x,y,z}*: *A*, *B*, *C* are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. *VR* is the maximum calibration range expressed in RMS voltage across the diode.
- *ConvF* and *Boundary Effect Parameters*: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DAS Y4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to *NORM_{x,y,z}* * *ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DAS Y version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- *Spherical isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



EX3DV4 SN:3731

July 16, 2010

Probe EX3DV4

SN:3731

Manufactured: October 19, 2009
Calibrated: July 16, 2010

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)



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DASY/EASY - Parameters of Probe: EX3DV4 SN:3731

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu V/(V/m)^2$) ^A	0.41	0.55	0.56	± 10.1%
DCP (mV) ^B	93.4	91.2	90.7	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	C	VR mV	Unc ^E (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	300	± 1.5%
			Y	0.00	0.00	1.00	300	
			Z	0.00	0.00	1.00	300	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm,X,Y,Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



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DASY/EASY - Parameters of Probe: EX3DV4 SN:3731

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] ^c	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
835	± 50 / ± 100	41.5 ± 5%	0.90 ± 5%	8.87	8.87	8.87	0.62	0.67 ± 11.0%
1900	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	7.47	7.47	7.47	0.58	0.66 ± 11.0%
2300	± 50 / ± 100	39.5 ± 5%	1.67 ± 5%	7.21	7.21	7.21	0.61	0.67 ± 11.0%
2600	± 50 / ± 100	39.0 ± 5%	1.96 ± 5%	6.88	6.88	6.88	0.36	0.92 ± 11.0%
3500	± 50 / ± 100	37.9 ± 5%	2.91 ± 5%	6.82	6.82	6.82	0.25	1.50 ± 13.1%
5200	± 50 / ± 100	36.0 ± 5%	4.66 ± 5%	4.65	4.65	4.65	0.40	1.80 ± 13.1%
5300	± 50 / ± 100	35.9 ± 5%	4.76 ± 5%	4.37	4.37	4.37	0.40	1.80 ± 13.1%
5500	± 50 / ± 100	35.6 ± 5%	4.96 ± 5%	4.45	4.45	4.45	0.40	1.80 ± 13.1%
5600	± 50 / ± 100	35.5 ± 5%	5.07 ± 5%	3.96	3.96	3.96	0.50	1.80 ± 13.1%
5800	± 50 / ± 100	35.3 ± 5%	5.27 ± 5%	4.08	4.08	4.08	0.50	1.80 ± 13.1%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



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DASY/EASY - Parameters of Probe: EX3DV4 SN:3731

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz]	Validity [MHz] [Ⓒ]	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
835	± 50 / ± 100	55.2 ± 5%	0.97 ± 5%	9.08	9.08	9.08	0.69	0.68 ± 11.0%
1900	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	7.33	7.33	7.33	0.58	0.71 ± 11.0%
2300	± 50 / ± 100	52.8 ± 5%	1.85 ± 5%	7.31	7.31	7.31	0.38	0.90 ± 11.0%
2600	± 50 / ± 100	52.5 ± 5%	2.16 ± 5%	7.15	7.15	7.15	0.33	0.97 ± 11.0%
3500	± 50 / ± 100	51.3 ± 5%	3.31 ± 5%	6.19	6.19	6.19	0.25	1.85 ± 13.1%
5200	± 50 / ± 100	49.0 ± 5%	5.30 ± 5%	4.16	4.16	4.16	0.55	1.95 ± 13.1%
5300	± 50 / ± 100	48.5 ± 5%	5.42 ± 5%	3.87	3.87	3.87	0.55	1.95 ± 13.1%
5500	± 50 / ± 100	48.6 ± 5%	5.65 ± 5%	3.43	3.43	3.43	0.60	1.95 ± 13.1%
5600	± 50 / ± 100	48.5 ± 5%	5.77 ± 5%	3.24	3.24	3.24	0.60	1.95 ± 13.1%
5800	± 50 / ± 100	48.2 ± 5%	6.00 ± 5%	3.59	3.59	3.59	0.65	1.95 ± 13.1%

[Ⓒ] The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

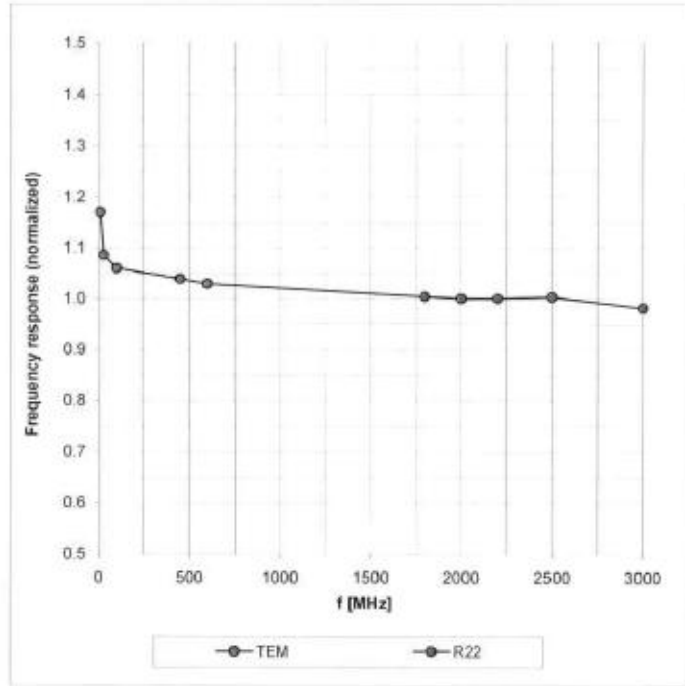


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Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



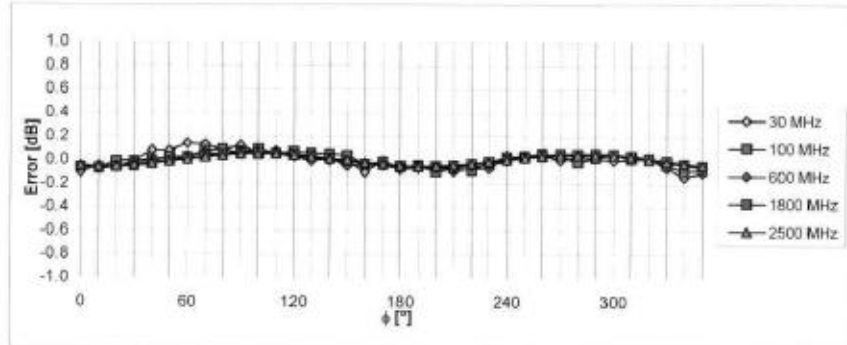
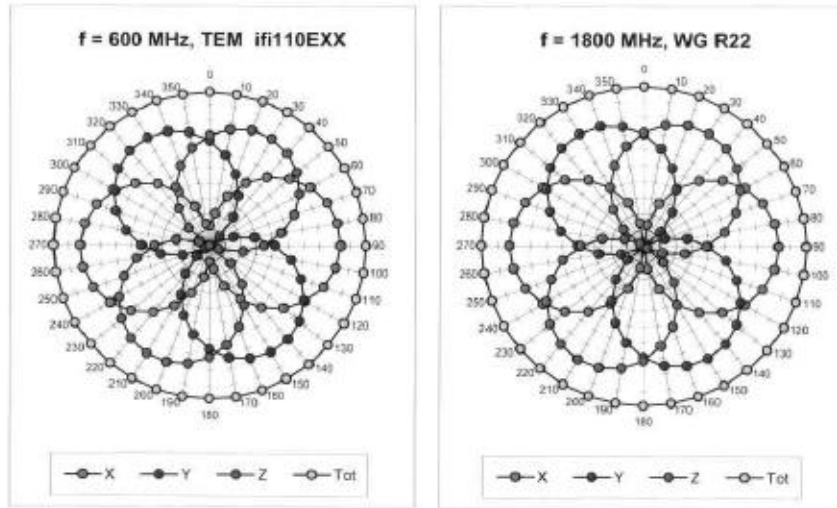
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)



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Receiving Pattern (ϕ), $\vartheta = 0^\circ$



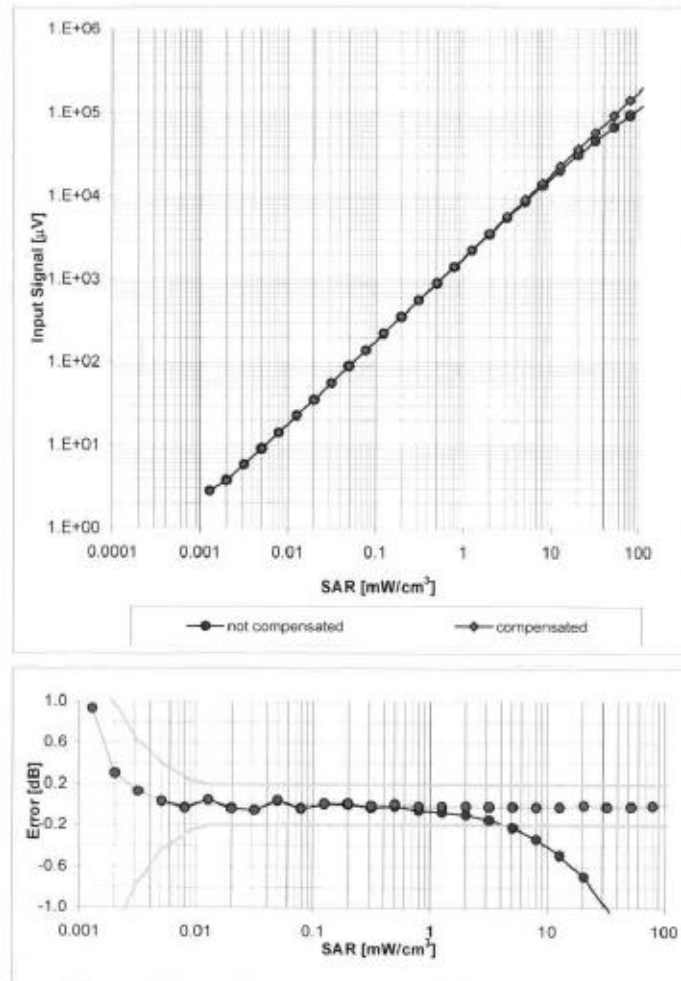
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)



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Dynamic Range $f(SAR_{head})$ (Waveguide R22, $f = 1800$ MHz)

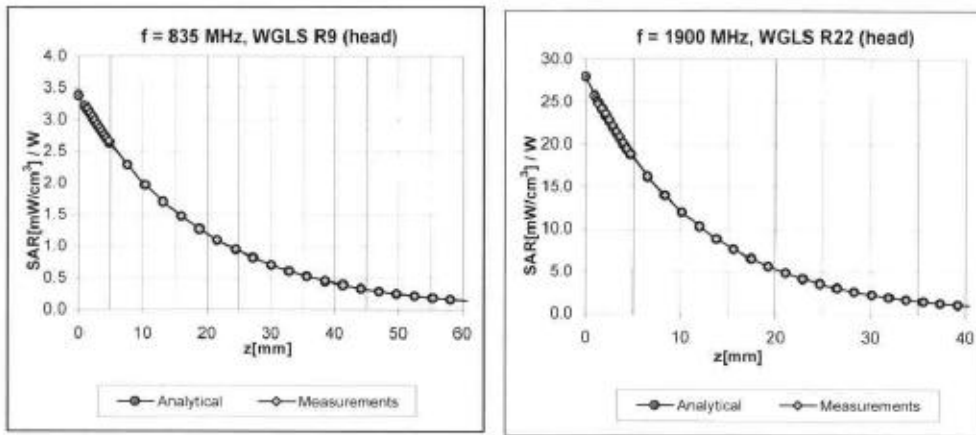


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

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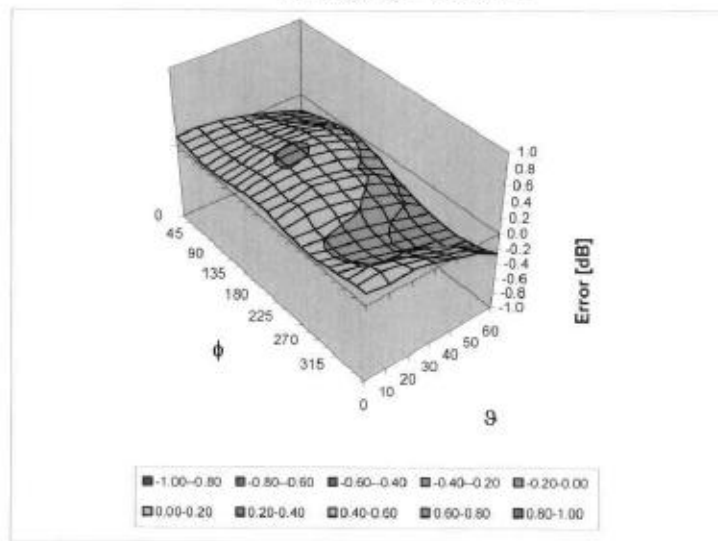
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Conversion Factor Assessment



Deviation from Isotropy in HSL

Error (ϕ, θ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ (k=2)



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Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	2 mm

Appendix D. Product Photos



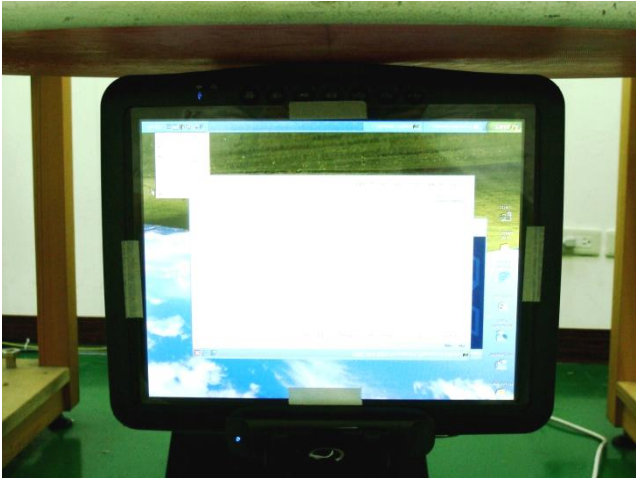
DUT with Battery 1



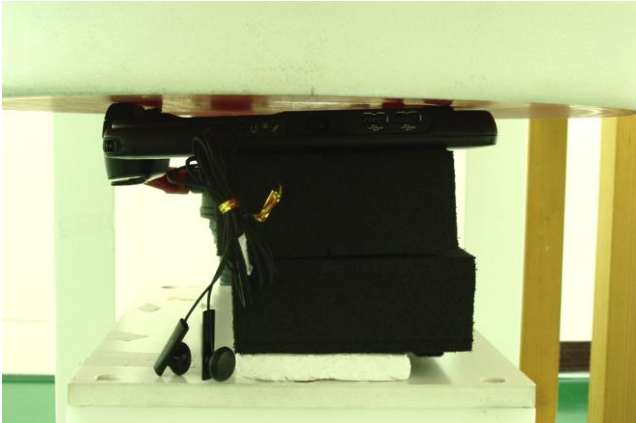
DUT with Battery 2



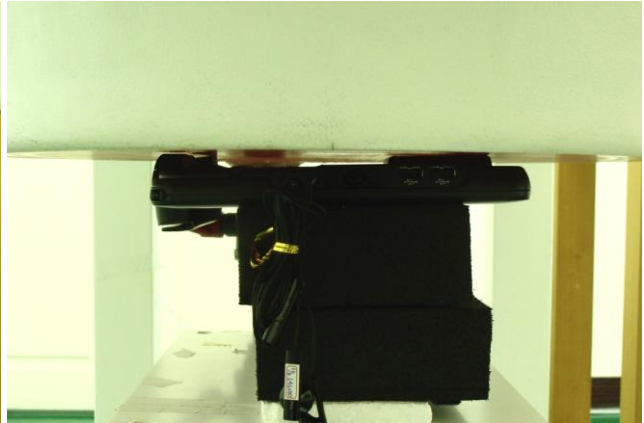
Appendix E. Test Setup Photos



Primary Landscape



Bottom of DUT Touching with Phantom 0 cm Gap
(DUT + Battery 1)



Bottom of DUT Touching with Phantom 0 cm Gap
(DUT + Battery 2)